

TLP192A

Telecommunications
Measurement and Control Equipment
Data Acquisition System
Measurement Equipment

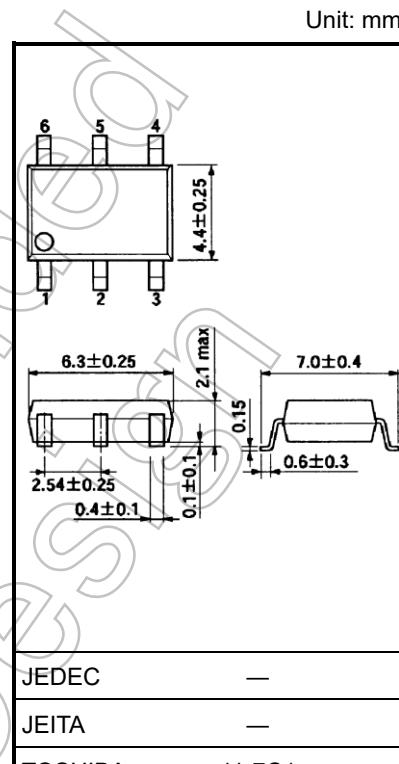
The Toshiba TLP192A consists of an infrared emitting diode optically coupled to a photo-MOSFET in a 6-pin SOP package.

Because of the low offset voltage at turn-on, this photorelay is suitable for analog signal switching, e.g. micro signal scan circuit of data acquisition system, subscriber circuit of digital exchange.

This photorelay has higher output current rating than phototransistor-type photocoupler; hence, it is suitable for use as On/Off control for high current.

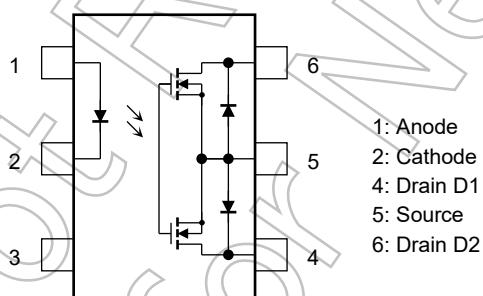
- 6-pin SOP (2.54SOP6): Height = 2.1 mm, pitch = 2.54 mm
- Normally open (1-form-A) device
- Peak off-state voltage: 60 V (min)
- Trigger LED current: 3 mA (max)
- On-state current: 400 mA (max)
- On-state resistance: 2 Ω (max)
- Isolation voltage: 1500 Vrms (min)
- UL-recognized: UL 1577, File No.E67349
- cUL-recognized: CSA Component Acceptance Service No.5A

File No.E67349

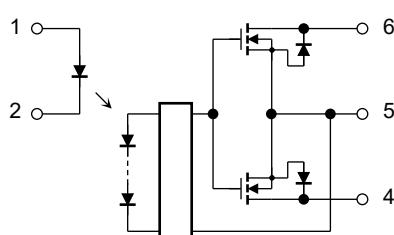


Weight: 0.13 g (typ.)

Pin Configuration (top view)



Schematic



Start of commercial production
2002-03

Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
LED	Forward current	I _F	50	mA
	Forward current derating (Ta ≥ 25 °C)	ΔI _F /°C	-0.5	mA/°C
	Peak forward current (100 μs pulse, 100 pps)	I _{FP}	1	A
	Reverse voltage	V _R	5	V
	Diode power dissipation	P _D	50	mW
	Diode power dissipation derating (Ta > 25 °C)	ΔP _D /°C	-0.5	mW/°C
	Junction temperature	T _j	125	°C
Detector	Off-state output terminal voltage	V _{OFF}	60	V
	On-state current	I _{ON}	400	
			400	mA
			800	
	Forward current derating (Ta ≥ 25 °C)	ΔI _{ON} /°C	-4.0	
			-4.0	mA/°C
			-8.0	
	Output power dissipation	P _O	256	mW
	Output power dissipation derating (Ta ≥ 25 °C)	ΔP _O /°C	-2.56	mW/°C
	Junction temperature	T _j	125	°C
	Storage temperature	T _{stg}	55 to 125	°C
	Operating temperature	T _{opr}	-40 to 85	°C
	Lead soldering temperature (10 s)	T _{sol}	260	°C
Isolation voltage (AC, 60 s, R.H. ≤ 60 %)		BVs	1500	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

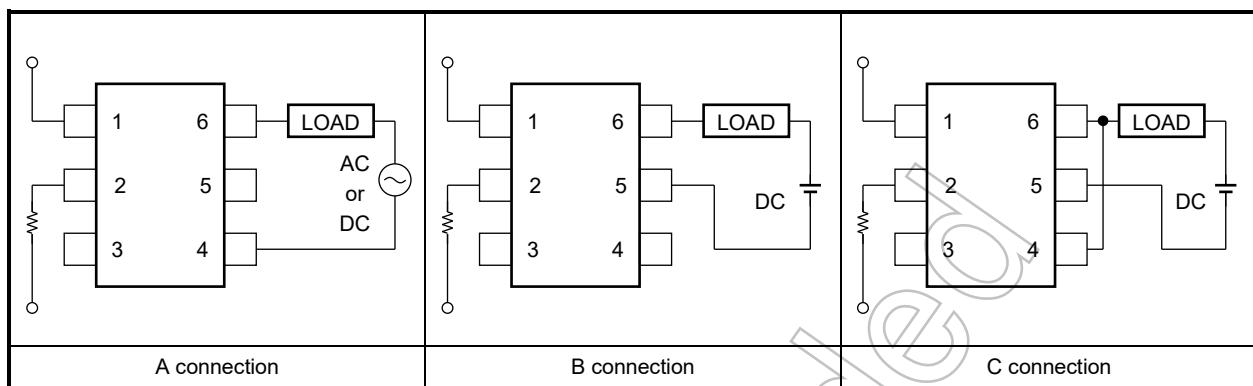
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 1: LED pins are shorted together. Detector pins are also shorted together.

Recommended Operating Conditions

Characteristics	Symbol	Min	Typ.	Max	Unit
Supply voltage	V _{DD}	—	—	48	V
Forward current	I _F	5	7.5	25	mA
On-state current	I _{ON}	—	—	400	mA
Operating temperature	T _{opr}	-20	—	65	°C

Note: Recommended operating conditions are given as a design guideline to obtain expected performance of the device. Additionally, each item is an independent guideline respectively. In developing designs using this product, please confirm specified characteristics shown in this document.

Circuit Connections

Not Recommended
for New Design

Electrical Characteristics ($T_a = 25^\circ\text{C}$)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
LED	Forward voltage	V_F	$I_F = 10 \text{ mA}$	1.0	1.15	1.3	V
	Reverse voltage	I_R	$V_R = 5 \text{ V}$	—	—	10	μA
	Capacitance between terminals	C_T	$V_F = 0 \text{ V}, f = 1 \text{ MHz}$	—	30	—	pF
Detector	Off-state current	I_{OFF}	$V_{OFF} = 60 \text{ V}$	—	—	1	μA
	Capacitance between terminals	C_{OFF}	$V = 0 \text{ V}, f = 1 \text{ MHz}$	—	130	—	pF

Coupled Electrical Characteristics ($T_a = 25^\circ\text{C}$)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Trigger LED current		I_{FT}	$I_{ON} = 400 \text{ mA}$	—	1.6	3	mA
Return LED current		I_{FC}	$I_{OFF} = 100 \mu\text{A}$	0.1	—	—	mA
On-state resistance	A connection	R_{ON}	$I_{ON} = 400 \text{ mA}, I_F = 5 \text{ mA}$	—	1	2	Ω
	B connection		$I_{ON} = 400 \text{ mA}, I_F = 5 \text{ mA}$	—	0.5	1	
	C connection		$I_{ON} = 800 \text{ mA}, I_F = 5 \text{ mA}$	—	0.25	—	

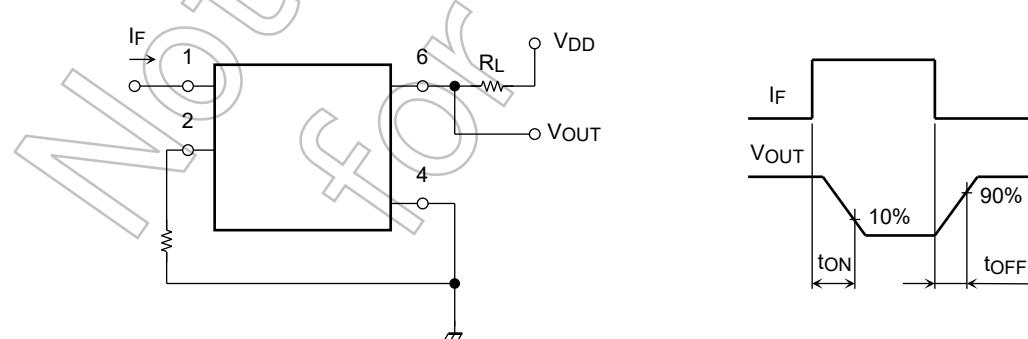
Isolation Characteristics ($T_a = 25^\circ\text{C}$)

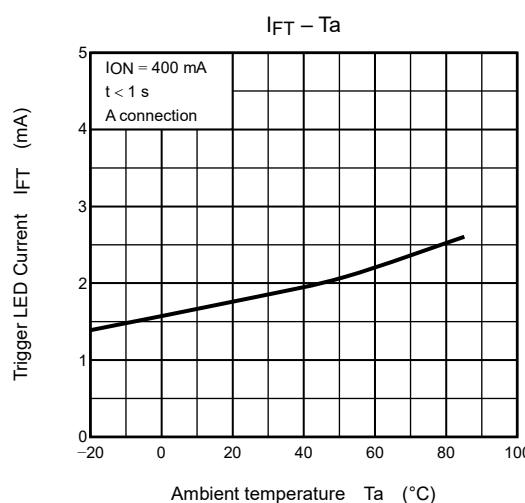
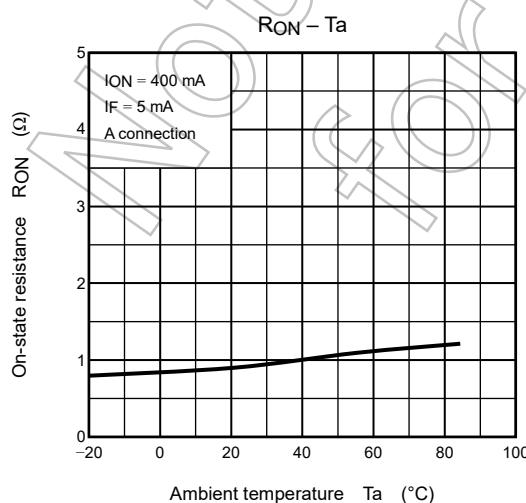
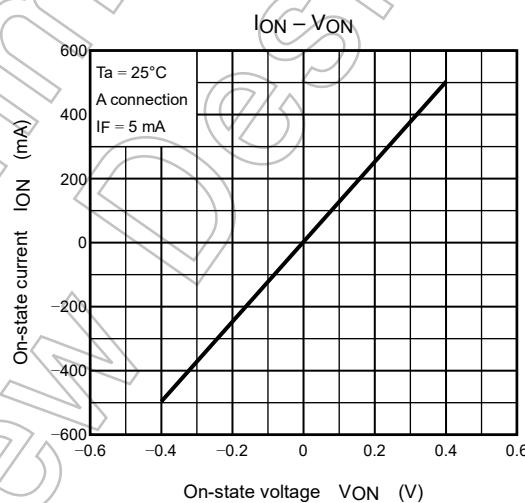
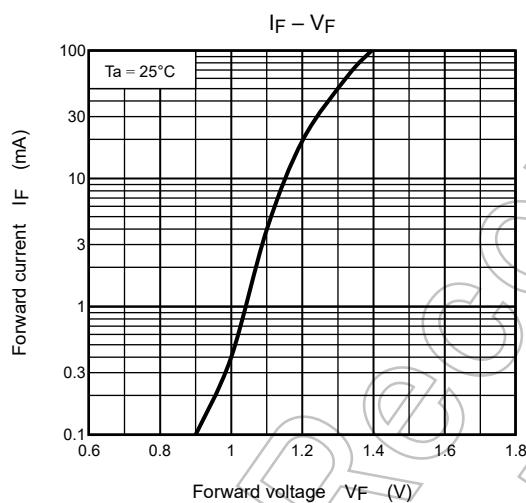
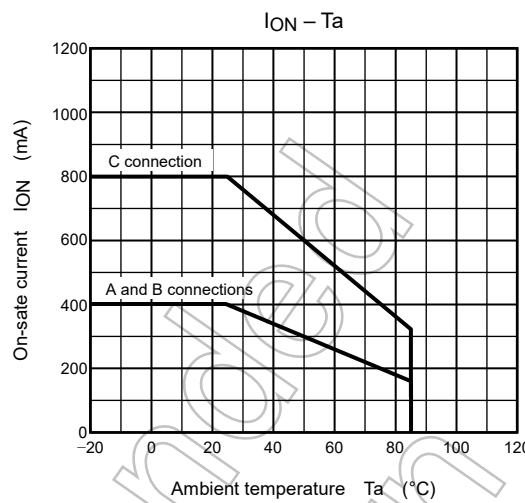
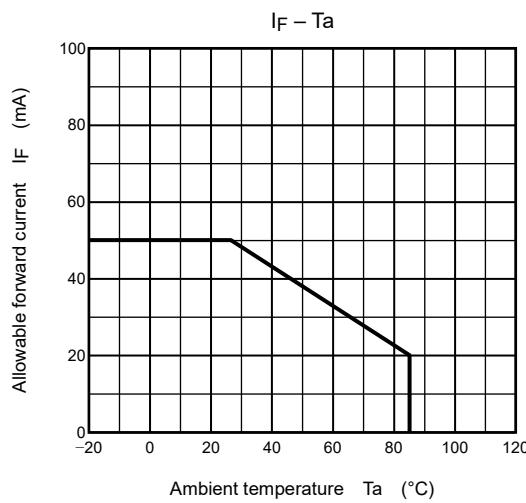
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Capacitance input to output		C_S	$V_S = 0 \text{ V}, f = 1 \text{ MHz}$	—	0.8	—	pF
Isolation resistance		R_S	$V_S = 500 \text{ V}, \text{R.H.} \leq 60\%$	5×10^{10}	10^{14}	—	Ω
Isolation voltage		BV_S	AC, 60 s	1500	—	—	Vrms

Switching Characteristics ($T_a = 25^\circ\text{C}$)

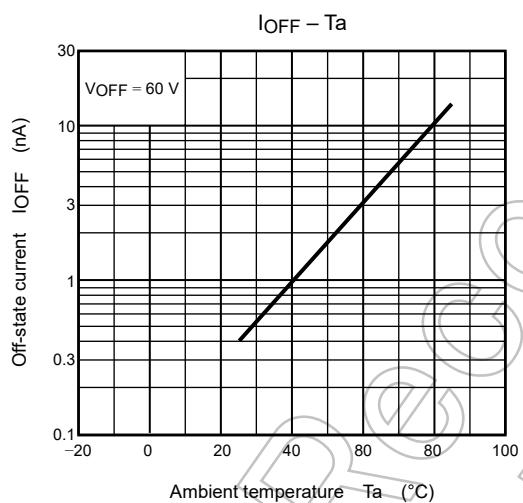
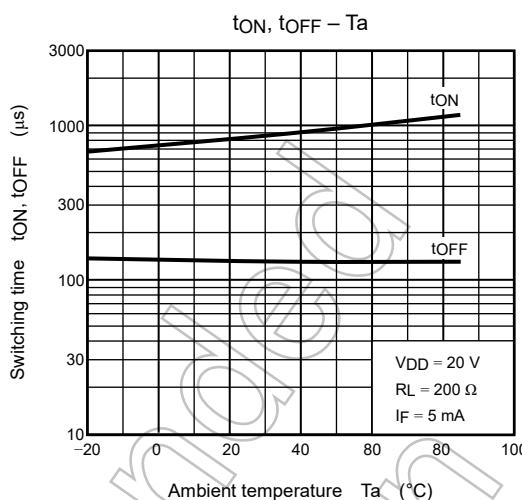
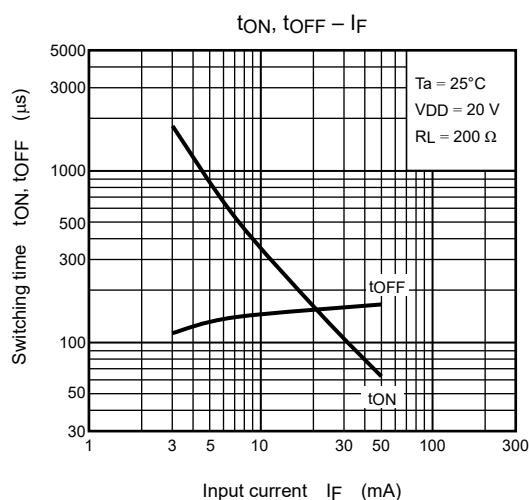
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Turn-on time		t_{ON}	$R_L = 200 \Omega$ $V_{DD} = 20 \text{ V}, I_F = 5 \text{ mA}$	—	0.8	2	ms
Turn-off time		t_{OFF}		—	0.1	0.5	

Note 2: Switching time test circuit





NOTE: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



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